

# Analysis of BTEX-MTBE by Purge and Trap (P&T) Concentration and Determination by GC/PID

PETROCHEMICAL SERIES



### Introduction

The analysis of Benzene, Toluene, Ethylbenzene, Xylenes, and Methyl-tert-butyl ether is a common analysis performed in many laboratories. BTEX compounds are naturally occurring constituents in crude oil and are created and used during the processing of refined petroleum products and during the production of chemical intermediates for many consumer products. BTEX compounds represent some of the most hazardous components in gasoline and are considered toxins of concern in fuels. These compounds, as well as MTBE a fuel oxygenate, are very mobile in soil and groundwater and are used as indicator compounds in various monitoring and clean-up programs such as the Underground Storage Tank (UST) Program.<sup>2</sup>

There are technology improvements available for analysis using the BTEX-MTBE method.



Figure 1. OI Analytical Eclipse 4760 Purge and Trap and the 4551A Autosampler and LV20 Detector



### Instrumentation

Purge and trap concentration was performed with an OI Analytical 4760 purge and trap with a 4551A autosampler. The LV-20 Standard Additions Module was used to inject 5 µl of internal standard and surrogate standard to each sample. The LV-20 employs high-speed valves that inject a programmed volume of standard with no excess or waste. GC separation and detection utilized an Agilent 7890A GC and OI Analytical 4450 tandem photoionization/flame ionization detector (PID/FID). The column used was a Restek Rxi-624Sil MS which can be programmed up to 320 °C if samples with very heavy compounds are being analyzed. Please see Table 1 for instrument parameters.

# **Experimental**

A seven-point calibration of 0.5-200 ppb was analyzed. MTBE and m, p-Xylenes were run at 1-400 ppb. Each analytical sample was spiked with 30 ppb  $\alpha$ , $\alpha$ , $\alpha$ -Trifluorotoluene internal standard and 30 ppb 1, 4-Difluorobenzene and Bromofluorobenzene surrogate standards. A Method Detection Limit (MDL) study was performed at 0.25 (0.5) ppb. An Initial Demonstration of Proficiency (IDP) was performed at 50 (100) ppb. A Lower Limit of Quantitation (LLOQ) verification was run at 0.5 (1) ppb.

## Results

Data was processed with Agilent OpenLab software. The %RSD and correlation co-efficient were calculated for each analyte and all Method 8021B/8000D criteria of  $\leq$  20% RSD for average response and correlation coefficient of  $\geq$  to 0.99 were met for the calibration. The MDL's met 40CFR criteria and IDP and LLOQ met Method 8021B/8000D criteria of 70-130% for the IDP and  $\pm$ 1-20% for the LLOQ.

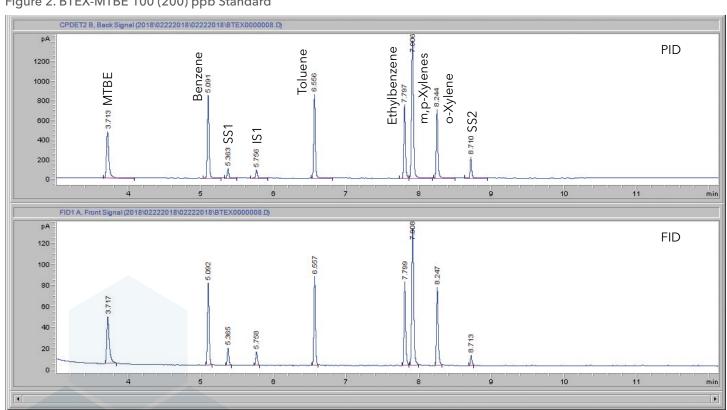
Table 1. Instrument Parameters

Purge-and-Trap	Eclipse 4760 P&T Sample Concentrator				
Trap	#7 trap; Tenax				
Purge Gas	Zero grade Helium at 40 mL/min				
Purge Time	8 min				
Purge Temperature	45 °C				
Sparge Mount	45 °C				
Temperature					
Desorb Time	0.5 min				
Bake Time	3 min				
OI #10 Trap	20 °C during purge				
Temperature	170 °C during desorb pre-heat				
	180 °C during desorb				
	200 °C during bake				
Water Management	120 °C during purge				
	Ambient during desorb 240 °C during bake				
Transfer Line	140 °C				
Temperature	140 C				
Six-port Valve Technique	140 °C				
I SIX-DOLL VAIVE TECHINQUE					
Gas Chromatograph	Agilent 7890A				
	Agilent 7890A Resktek Rxi-624Sil MS				
Gas Chromatograph	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film				
Gas Chromatograph Column	Agilent 7890A Resktek Rxi-624Sil MS				
Gas Chromatograph Column Carrier Gas	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium				
Gas Chromatograph Column Carrier Gas Inlet Temperature	Agilent 7890A Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 μm film Zero grade helium 240 °C				
Gas Chromatograph Column Carrier Gas Inlet Temperature Inlet Liner	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium 240 °C  1 mm straight				
Gas Chromatograph Column Carrier Gas Inlet Temperature Inlet Liner Column Flow rate	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium  240 °C  1 mm straight  0.8 mL/min				
Gas Chromatograph Column Carrier Gas Inlet Temperature Inlet Liner Column Flow rate Split Ratio	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium 240 °C  1 mm straight  0.8 mL/min  50:1				
Gas Chromatograph Column Carrier Gas Inlet Temperature Inlet Liner Column Flow rate Split Ratio	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium 240 °C  1 mm straight  0.8 mL/min  50:1  50 °C for 1.5 min 16 °/min to 160 °C 40° /min to 230 °C				
Gas Chromatograph Column Carrier Gas Inlet Temperature Inlet Liner Column Flow rate Split Ratio	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium  240 °C  1 mm straight  0.8 mL/min  50:1  50 °C for 1.5 min 16 °/min to 160 °C 40° /min to 230 °C Hold 2.0 minutes				
Gas Chromatograph Column  Carrier Gas Inlet Temperature Inlet Liner Column Flow rate Split Ratio Oven Program	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium 240 °C  1 mm straight  0.8 mL/min  50:1  50 °C for 1.5 min 16 °/min to 160 °C 40° /min to 230 °C  Hold 2.0 minutes  Total GC run time is 12.125 minutes				
Gas Chromatograph Column Carrier Gas Inlet Temperature Inlet Liner Column Flow rate Split Ratio	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium  240 °C  1 mm straight  0.8 mL/min  50:1  50 °C for 1.5 min 16 °/min to 160 °C 40° /min to 230 °C Hold 2.0 minutes  Total GC run time is 12.125 minutes				
Gas Chromatograph Column  Carrier Gas Inlet Temperature Inlet Liner Column Flow rate Split Ratio Oven Program  Detector Base Temperature	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium 240 °C  1 mm straight  0.8 mL/min  50:1  50 °C for 1.5 min 16 °/min to 160 °C 40° /min to 230 °C  Hold 2.0 minutes  Total GC run time is 12.125 minutes				
Gas Chromatograph Column  Carrier Gas Inlet Temperature Inlet Liner Column Flow rate Split Ratio Oven Program  Detector Base Temperature Sweep Flow (H2)	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium  240 °C  1 mm straight  0.8 mL/min  50:1  50 °C for 1.5 min 16 °/min to 160 °C 40° /min to 230 °C Hold 2.0 minutes  Total GC run time is 12.125 minutes				
Gas Chromatograph Column  Carrier Gas Inlet Temperature Inlet Liner Column Flow rate Split Ratio Oven Program  Detector Base Temperature Sweep Flow (H2) Air flow	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium  240 °C  1 mm straight  0.8 mL/min  50:1  50 °C for 1.5 min 16 °/min to 160 °C 40° /min to 230 °C Hold 2.0 minutes  Total GC run time is 12.125 minutes  4450 PID/FID  220 °C				
Gas Chromatograph Column Carrier Gas Inlet Temperature Inlet Liner Column Flow rate Split Ratio Oven Program  Detector Base Temperature Sweep Flow (H2)	Agilent 7890A  Resktek Rxi-624Sil MS 30 meters, 0.25 mm ID, 1.4 µm film  Zero grade helium  240 °C  1 mm straight  0.8 mL/min  50:1  50 °C for 1.5 min 16 °/min to 160 °C 40° /min to 230 °C Hold 2.0 minutes Total GC run time is 12.125 minutes  4450 PID/FID  220 °C  35 mL/min				

Table 2. Calibration Data

Compound	RL (ppb)	Avg RF	% RSD	Coeff. of Det (R <sup>2</sup> )	MDL (ppb)	IDP Precision (% RSD)	IDP Accuracy (% Rec)	LLOQ (% Rec)
$\alpha, \alpha, \alpha$ -Trifluorotoluene	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A
MTBE	1.0	1.257	4.75	0.9992	0.486	2.70	108	104
Benzene	0.5	3.389	4.22	0.9992	0.034	0.89	95.4	92.0
1,4-Difluorobenzene (SS)	N/A	1.172	0.52	0.9999	N/A	0.45	97.5	N/A
Toluene	0.5	3.124	4.37	0.9992	0.052	1.22	93.6	86.6
Ethylbenzene	0.5	2.632	5.89	0.9993	0.016	0.91	98.0	92.2
m,p-Xylenes	1.0	3.033	5.47	0.9992	0.072	1.03	97.7	89.4
o-Xylene	0.5	2.561	4.93	0.9994	0.050	0.79	99.5	90.0
Bromofluorobenzene (SS)	N/A	2.474	1.93	0.9999	N/A	1.57	99.6	N/A

Figure 2. BTEX-MTBE 100 (200) ppb Standard



### **Conclusions**

The 4760/4551A purge and trap system coupled with the 4450 PID/FID gave excellent results using a very simple and rugged methodology. The total GC cycle time from injection to injection totaled 15 minutes, making this a fast method as well.

### References

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